

SILICON PHOTODIODE

PRELIMINARY ENGINEERING DATA SHEET

FEATURES

- Low dark current
- Fast response
- Blue to IR spectral range
- Low junction capacitance

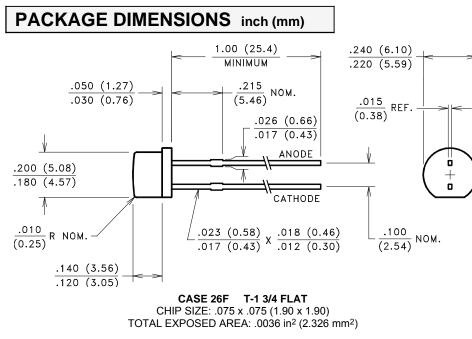
PRODUCT DESCRIPTION

This VTP processed P on N planar silicon photodiode is housed in a clear, T-1 3/4 end-looking package.

These diodes exhibit low dark current under reverse bias. The VTP process offers low capacitance, resulting in fast response times.

ELECTRO-OPTICAL CHARACTERISTICS @ 25° C

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNITS
SHORT CIRCUIT CURRENT @ 100 fc, 2850 K	lsc	21			μA
SENSITIVITY @ PEAK	S _R		0.6		A/W
DARK CURRENT @ V _R = 10 V	I _D			25	nA
REVERSE BREAKDOWN VOLTAGE @ 100 µA	V _{BR}	30			V
JUNCTION CAPACITANCE @ V _R = 0 V, 1 MHz	Сл			100	pF
ANGULAR RESPONSE (50% RESPONSE POINT)	$\theta_{1/2}$		±70		Degrees

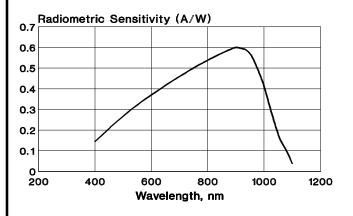


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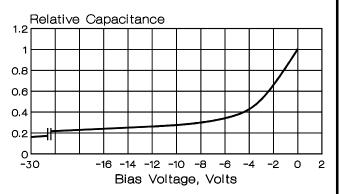
GENERAL CHARACTERISTICS						
PARAMETER	SYMBOL	TYPICAL RATING	UNITS			
OPEN CIRCUIT VOLTAGE @ 100 fc, 2850 K SOURCE	Voc	420	mV			
PEAK SPECTRAL RESPONSE @ 25°C	λ_{pk}	920	nm			
SPECTRAL APPLICATION RANGE	λ_{range}	400 - 1100	nm			
RISE/FALL TIMES @ 800 nm, V _R =10 V, R _L = 50 Ω	t _R / t _F	20	ns			
TEMPERATURE COEFFICIENT SHORT CIRCUIT CURRENT @ 2850 K SOURCE DARK CURRENT @ V _R = 10 V OPEN CIRCUIT VOLTAGE	TC Isc TC I _D TC V _{OC}	+0.20 +11.0 -2.0	% / °C % / °C mV/ °C			
TEMPERATURE RANGE, OPERATING & STORAGE	T _{AMB}	– 40 to +100	°C			

TYPICAL CHARACTERISTIC CURVES

ABSOLUTE SPECTRAL RESPONSE



RELATIVE JUNCTION CAPACITANCE vs BIAS VOLTAGE (REFERRED TO ZERO BIAS)



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